

Study of Diamond Film Interface Structure and Contacting Area

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High purity diamond film has been grown by refined Combustion Flame method with high oxygen proportion. Snapshots of time series of the diamond film forming were taken and a model was derived. By observing the period of seeding to coalescing of diamond crystals to form film, it is realized that the contacting area is small and the calculated value was less than 15%. It is also found that the base layer of the film was porous as a result of non-uniform crystal growth. To enhance adhesion of the film, the contacting area between the film and the substrate must be increased, and the porous base layer must be thin and dense as much as possible. To achieve that, very high and uniform nucleation is the key. Under this view, the nanocrystalline diamond film on smooth substrate is preferred than rough surface to have strong adhesion.

Keywords: *diamond film, combustion flame, interfacial structure, contacting area*

1. Introduction

Diamond possesses a combination of extreme properties, such as highest hardness, very low friction coefficient and highest thermal conductivity. Chemical vapor deposition (CVD) enables the manufacturing of diamond in the form of film at low cost. As one of CVD, Combustion Flame methods deposit diamond at high rates (typically 100-1,000 $\mu\text{m/h}$), but often only over very small localized areas and with poor process control resulting in poor quality films. However, the quality of the films by Combustion Flame methods could be improved and the acceptable quality diamond film could be produced for applications such as an abrasive and coating on cutting tool inserts, drill bits, borer, milling cutter, etc.

The diamond film then is an ideal coating for tools with cemented carbide as substrate materials. The biggest concern is the poor adhesion of the diamond film from the detrimental effects of the binders (e.g. Co) on diamond nucleation. With reduction of surface cobalt, adhesion of diamond film with WC substrate could be enhanced remarkably². Mechanical or chemical pretreatments, interlayers or combinations of these methods are applied to improve nucleation and adhesion strength³⁻⁷. All of these techniques are related to the final film structure which determined the adhesion strength. However, no detailed investigation of the structure of the film interface was performed to increase understanding the film adhesion strength numerically.

The aim of this study was to employ improved high-oxygen combustion flame to produce high quality diamond film on the surface of WC-Co, which was pretreated for high nucleation, to investigate the formation of the film step by step and to identify any aspects of the film that could be improved to increase the adhesion of the diamond film.

2. Experimental

The refined Combustion Flame CVD was employed for fabrication of continuous diamond film with high purity. Figure 1 shows a schematic illustration of the diamond coating apparatus used in this

study. Oxygen (O_2) with 99.8% purity and acetylene (C_2H_2) with 99.5% purity were used. Gas flow rate was measured with flowmeters (Gilmont instruments GF6541-1215 and GF-6541-1225). The welding torch was COMET with a No. 8 tip.

The substrates were WC/Co (4 wt. (%) Co) with the dimension of 9 x 9 x 5 mm. with slight tapering. The substrate was inserted in the slot on the copper box with water-cooling. The temperature was monitored at the side of the specimen, using thermocouple type K with the temperature reader (Carlo Gavazzi Instruments SPA LDI 35). Substrate in this study was pretreated by immersion in etchant for 30 seconds at room temperature. The etchant composition was listed in ASTM E407⁸. Then, it was followed by scratching treatment with 1 μm diamond powder on the polishing cloth for 1 minute. After scratching, the substrate was cleaned with detergent, distilled water and dried. For examination of the surface morphology, the scanning electron microscope JSM-6301F was employed. The identification of the presence of diamond and other forms of carbon was performed using Renishaw Ramanscope System 2000.

The experiments were performed in air at normal atmospheric pressure. Acetylene and oxygen flow rates were 1.21 and 1.37 $\text{L}\cdot\text{min}^{-1}$, respectively. The ratio of oxygen per acetylene ($\text{O}_2/\text{C}_2\text{H}_2$) was 1.13. The substrate was located at 1 mm. away from the tip of the inner flame. The temperature of the substrate was maintained at 700 °C. The time for growing diamond film was varied from 0 to 10 minutes. A series of snapshots of various deposition times from nucleation to film forming was taken. Top-viewed 2-dimensional SEM micrographs were transformed to schematic drawing model of film forming. The number of seeds or nuclei was plotted against time. Contacting area percentage was calculated.

3. Results and Discussion

Theoretically, the acetylene/oxygen flow ratio for producing diamond film is equal to one. However, in practice this ratio as determined by the read-out of the flowmeters, is different from unity

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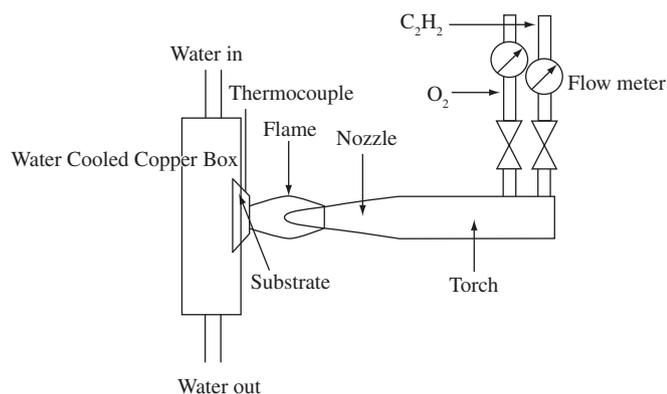


Figure 1. Schematic illustration of the diamond coating apparatus.

due to the burner geometry dependent kinetics of the combustion process and the cylinder pressure dependent take-up of acetone in the acetylene flow⁹. Higher oxygen has been incorporated to enhance the etching of non-diamond phases¹⁰. Refined combustion CVD with high oxygen proportion was employed to produce high quality diamond film in this study.

Micrographs of the growth of diamond at various times are shown in Figure 2. Figure 2a shows the microstructure after 3 minutes, it is similar to that of the original as-treated surface. At 3.5 minutes, diamond nuclei were noticeable- they grew larger and increased in number during the 4th and 5th minute (Figures 2c and d). The diamond crystals started to join into a porous film (Figure 2e) and a dense film after 10 minutes (Figure 2f). The diamond crystals in the film are almost oriented with {111} facets. Raman spectrum showed that the film was composed of pure diamond with no other forms of carbon (Figure 3).

The crystal density was plotted in Figure 4. The nucleation density or the diamond crystal density before forming film was 5.5×10^7 crystals.cm⁻² after 3.5 minutes and increased to the highest value of about 1.2×10^8 crystals.cm⁻² after 4 minutes. As time increased, the diamond crystal density decreased rapidly to the approximate value of 6.5×10^7 crystals.cm⁻². It has shown that the crystal density of the film is less than the observed maximum. The diamond crystal density does not depend only on the nucleation density but also the competitive growth among diamond crystals. The competitive growth results in nearly half the maximum value.

Figure 5 shows the cross-sectional view of the fracture of the film that peeled off after prolonged exposure to the flame (20 minutes). The crystal morphology in the thick film was columnar and dense. For common Combustion Flame method, the growth of diamond was found to be dendritic¹¹ and the film was porous, but this refined Combustion Flame CVD and surface pretreatment gave the columnar structure as achieved by another improved combustion method¹². Although this refined combustion method could produce the diamond film with improved characteristics, the coating area was limited to just 5 mm. in diameter, and the growth rate was measured to be just 10 μ m/h as a trade-off for high quality diamond. The growth rate was highest at the center and lowest at the perimeter of the coating area. These limitations could be improved further by the modification of the instruments to increase the coating area and uniformity throughout the coating area.

4. Growth Model of Diamond Film with High Nucleation Density

Derived from this study, a specific growth model of diamond film was constructed (Figure 6). The cross-sectional views were reasonably induced from the top-viewed SEM micrographs in Figure 2. The model shows that a number of diamond nuclei originate on the surface at the early exposure to the flame, especially at grooves (Figure 6a). As time increases, the number of nuclei increases and some grow larger. At the next stage, some crystals touch the neighboring ones. Small islands of crystals are formed and join into a porous layer (Figure 6e). Competitive growth becomes crucial when the diamond crystals touch the others and some crystals grow larger at the expense of the others. This results in decrease of crystals density as found experimentally (Figure 4). When joining of islands of diamond crystals completes, a continuous film is produced (Figure 6f). The growth of the diamond crystals in the film is then in the direction of the supply of carbon source (or to the flame), resulting in dense columnar structure (Figure 6g).

From this model, the footprint of the film is not a replica of the substrate surface and the base layer is also porous (Figure 6h). These important aspects are not shown in an earlier model¹¹ which does not take surface roughness and competitive growth into consideration. There are reports on the porous intermediate layer of TiC on titanium substrate¹³, and some porous structure in the diamond film¹.

As the adhesion strength is directly related to the contacting area between the film and the substrate, neither the bottom area of the film nor the area of the substrate surface under the film could be counted as contacting area. The best estimation of contacting area should rather be implied from the crystal density of the first continuous film, which is 6.5×10^7 crystals.cm⁻² (Figure 4). The early higher nucleation density (Figure 4) could not be employed since some crystals do not grow fast enough to participate in the forming of the film before the film covers the surface and the further growth of crystals underneath is prohibited.

The contacting area of the film is the product of crystal density and the contacting area of each crystal. Since each diamond crystal is bound, the substrate through its apex only^{6,14}, it is assumed that the crystal size at the first noticeable stage, 0.3-0.5 μ m. from Figure 2b, is the diameter of contacting area of each crystal. With the crystal density of 6.5×10^7 crystals.cm⁻², the contacting area of 1 cm² film is just 0.05-0.14 cm², or as low as 5-14% of the substrate area, and will be less if the surface roughness is considered. The adhesion strength could be much further improved by increasing contacting area via increased nucleation density.

There are emerging techniques to increase the nucleation density substantially, i.e., negative bias¹⁵⁻²⁰, seeding with nano-particles²¹, nano-layer of diamond-like carbon interlayer²² and very low pressure¹⁴. These techniques could produce very high nucleation density up to 10^{11} crystals.cm⁻². By varying pressure of the synthesis chamber, nucleation density range of 5×10^{10} crystals.cm⁻² could be achieved¹⁴ with the approximated nucleus diameter of 0.04 μ m. The total contacting area is calculated to be 62.9%. To increase the contacting area to 100%, the nucleation density must be increased to 8×10^{10} crystals.cm⁻². At 100% contacting area, continuous film is formed with the nanocrystals of estimated nucleus diameter of approximate 40 nm.

Another important aspect of the film structure limiting adhesion strength is the porous interface layer. The existence of porous interface layer is in disagreement with the idea of the film failure under the stress from the thermal expansion mismatch between diamond film and substrate²³. High porosity layer is a good stress relaxation buffer for the thermal expansion mismatch. The peeling-off failure

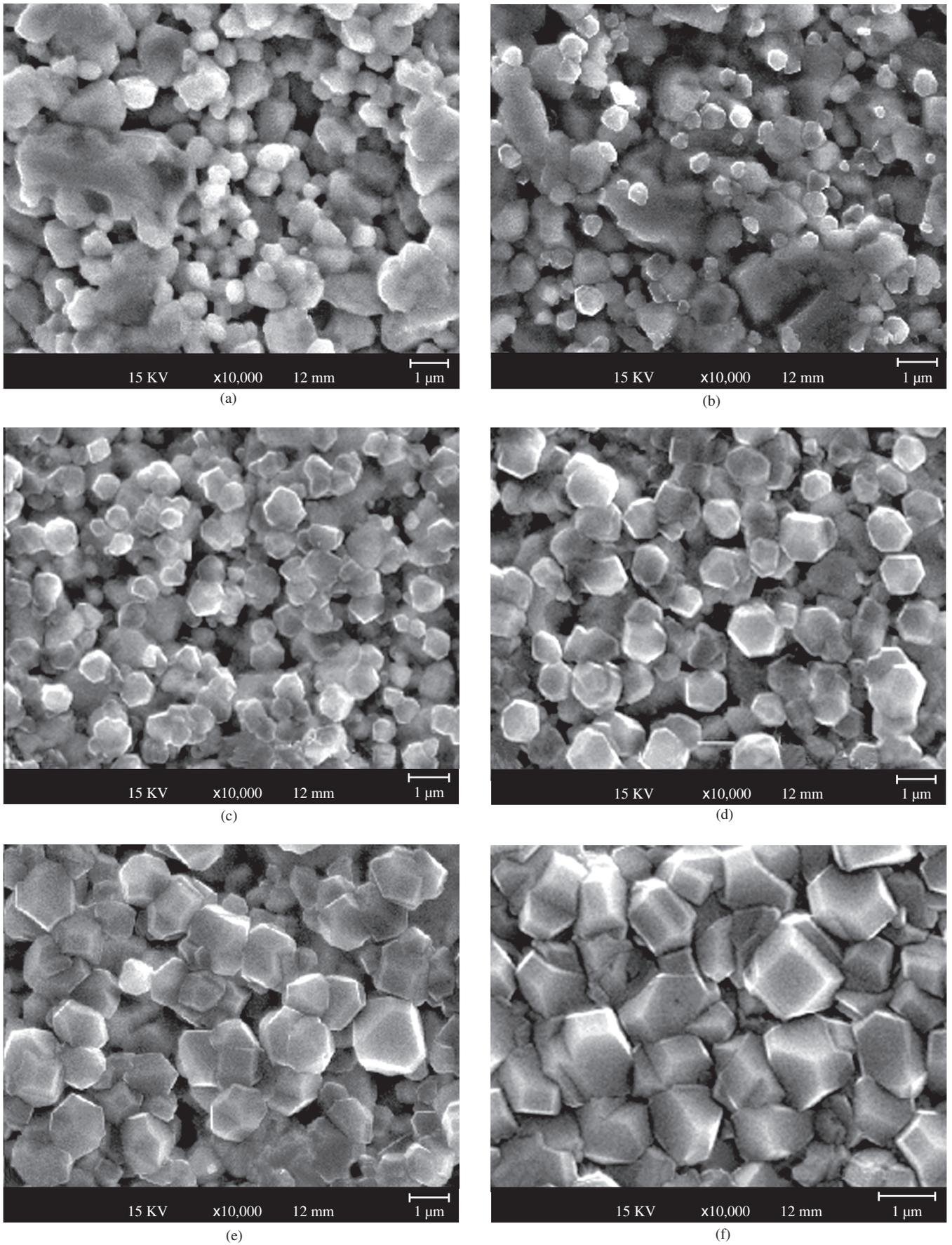


Figure 2. Micrographs of diamond crystal growth at various time a) 3 minutes, b) 3.5 minutes, c) 4 minutes, d) 5 minutes, e) 6 minutes and f) 10 minutes.

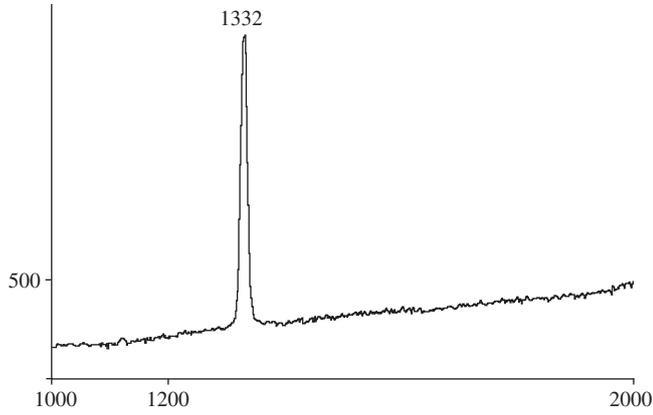


Figure 3. Raman Spectrum of the diamond film.

is more probably caused by the stress in reinforced directions on thin stems in the porous layer by the thermal expansion/contraction from rough substrate surface. The stress in the diamond film detected by Raman spectroscopy²⁴ is more likely to be the result of the competitive growth and the thermal expansion mismatch among crystals with different orientation, rather than the thermal expansion mismatch of diamond film and substrate. The thickness and porosity of this porous layer is the function of nucleation density, substrate surface roughness, nucleation uniformity in position and time, crystal orientation and growth rate. The rougher the substrate surface, the greater the possibility for the thicker porous layer. The porous interface layer is considered the weakest part; smooth substrate reduced the porous interface layer to the minimum thickness.

To develop a dense interface with high contacting area, high uniformity of nucleation and smooth substrate surface is required. The requirement for high uniformity of nucleation and smooth substrate surface is in contradiction with the idea of increasing adhesion through

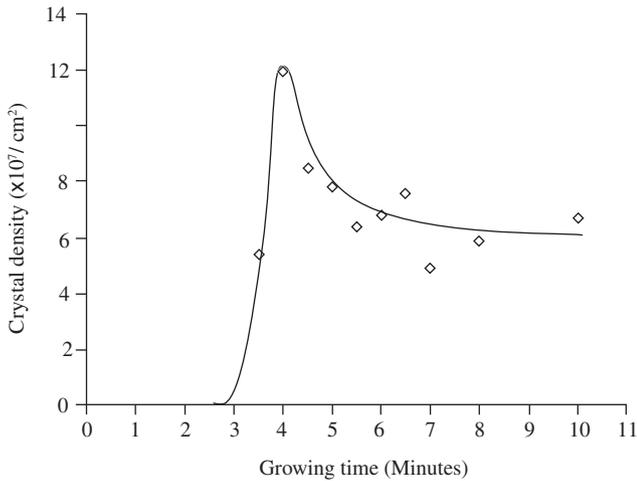


Figure 4. Crystal density versus growing time.

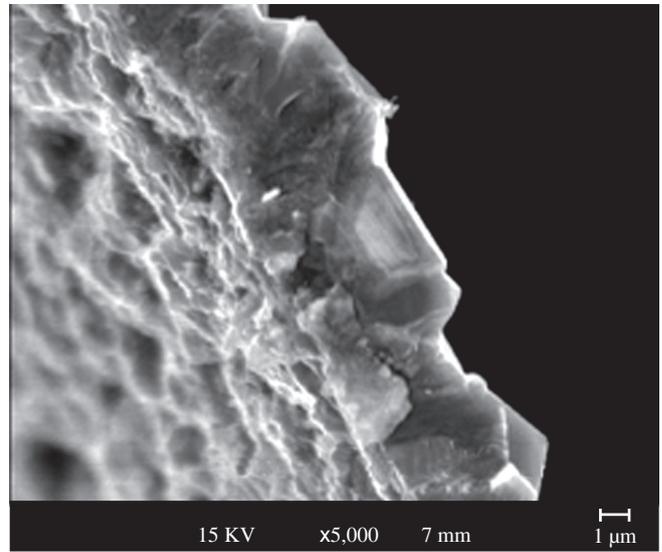
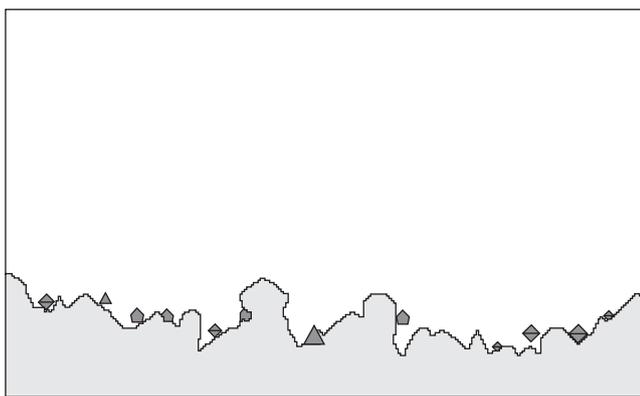
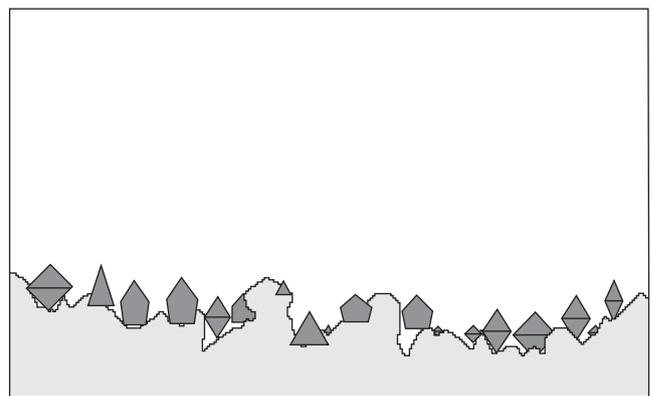


Figure 5. Cross-sectional view of diamond film.



(a)



(b)

Figure 6. Model of the formation of the diamond film from a) to h).

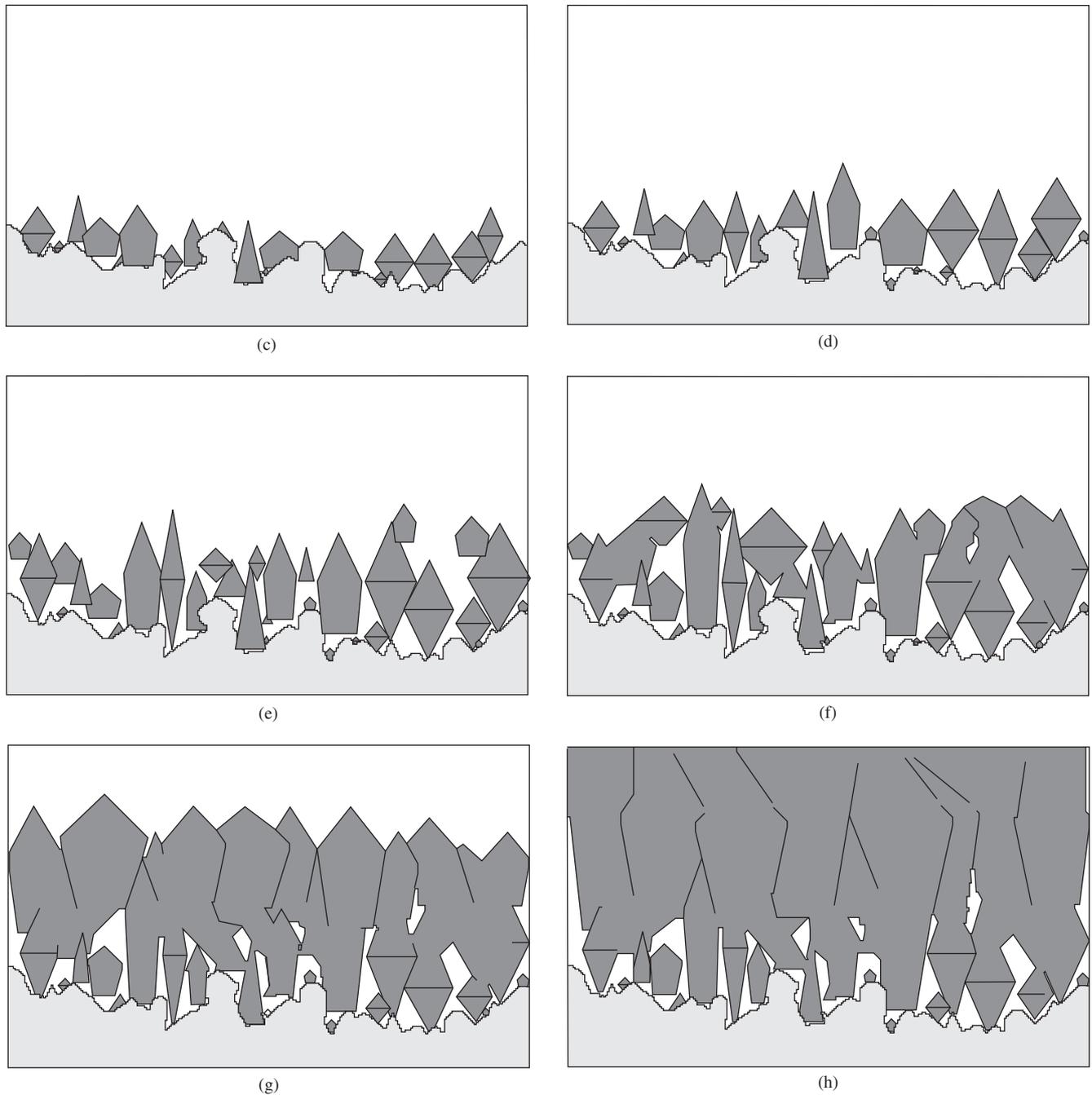


Figure 6 (Continued). Model of the formation of the diamond film from a) to h).

physical interlocking mechanism by increasing the roughness of the substrate surface. It is the porous interface layer that is not considered in physical interlocking mechanism.

5. Summary

High purity diamond film has been grown by refined Combustion Flame method with high oxygen proportion. Snapshots of time series of the diamond film forming were taken and a model was derived. From the model, it is clear that the interface of the film was porous. The porosity and thickness of this porous interface depend upon the nucleation density and growth rate. For the continuous diamond film with crystalline size of a few micron, the contacting area between the

film and the substrate was found to be only 5-14% of the total substrate surface area. This value helps us to understand numerically how poor the adhesion was. To enhance adhesion of the film, the contacting area between the film and the substrate must be increased, and the porous interface layer must be thin and dense as much as possible. To achieve that, very high and uniform nucleation is the key. Under this view, the nanocrystalline diamond film on smooth substrate is preferred to have stronger adhesion

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